

**Search Notes**

Application/Control No.

10/630,948

Examiner

Phi D. A

Applicant(s)/Patent under  
Reexamination

HANG, WEI ZHAN

Art Unit

3637

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PA see attached		